

MOTOROLA SEMICONDUCTOR TECHNICAL DATA

**NPN
TIP33
TIP33A
TIP33B
TIP33C**

**PNP
TIP34
TIP34A
TIP34B
TIP34C**

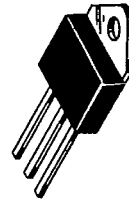
COMPLEMENTARY SILICON HIGH-POWER TRANSISTORS

... for general-purpose power amplifier and switching applications.

- 10 A Collector Current
- Low Leakage Current — $I_{CEO} = 0.7 \text{ mA}$ @ 30 and 60 V
- Excellent dc Gain — $h_{FE} = 40 \text{ Typ}$ @ 3.0 A
- High Current Gain Bandwidth Product — $h_{fe} = 3.0 \text{ min}$ @ $I_C = 0.5 \text{ A}$, $f = 1.0 \text{ MHz}$

10 AMPERE COMPLEMENTARY SILICON POWER TRANSISTORS

**40-100 VOLTS
80 WATTS**



MAXIMUM RATINGS

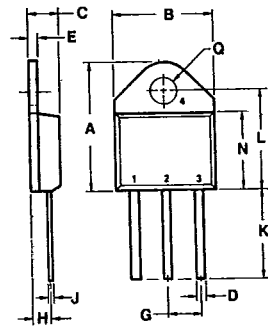
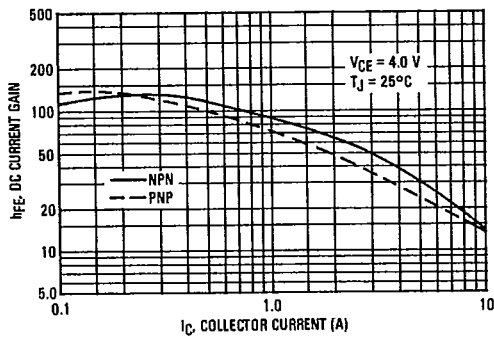
Rating	Symbol	TIP33 TIP34	TIP33A TIP34A	TIP33B TIP34B	TIP33C TIP34C	Unit
Collector-Emitter Voltage	V_{CEO}	40 V	60 V	80 V	100 V	Vdc
Collector-Base Voltage	V_{CB}	40 V	80 V	80 V	100 V	Vdc
Emitter-Base Voltage	V_{EB}	5.0				Vdc
Collector Current — Continuous	I_C	10				Adc
Peak (1)		15				
Base Current — Continuous	I_B	3.0				Adc
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	80				Watts
		0.64				
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +150				$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.56	$^\circ\text{C}/\text{W}$
Junction-To-Free-Air Thermal Resistance	$R_{\theta JA}$	35.7	$^\circ\text{C}/\text{W}$

(1) Pulse Test: Pulse Width = 10 ms, Duty Cycle $\leq 10\%$.

FIGURE 1 — DC CURRENT GAIN



STYLE 1:

1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	20.32	21.08	0.800	0.830
B	15.49	15.90	0.610	0.626
C	4.19	5.08	0.165	0.200
D	1.02	1.65	0.040	0.065
E	1.35	1.65	0.053	0.065
G	5.21	5.72	0.205	0.225
H	2.41	3.20	0.095	0.126
J	0.38	0.64	0.015	0.025
K	12.70	15.49	0.500	0.610
L	15.88	16.51	0.625	0.650
N	12.19	12.70	0.480	0.500
Q	4.04	4.22	0.159	0.165

**CASE 340-02
TO-218C**

3

T-33-13

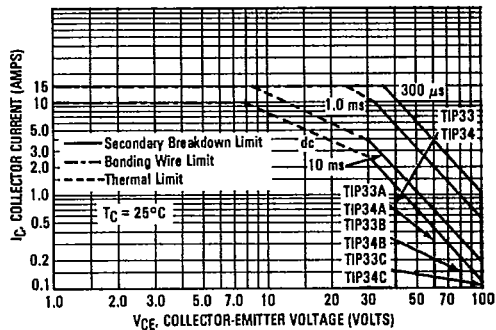
T-33-21

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Sustaining Voltage (1) ($I_C = 30\text{ mA}, I_B = 0$)	$V_{CE(sus)}$	40 60 80 100	—	Vdc
Collector-Emitter Cutoff Current ($V_{CE} = 30\text{ V}, I_B = 0$)	I_{CEO}	—	0.7	mA
Collector-Emitter Cutoff Current ($V_{CE} = 60\text{ V}, I_B = 0$)	I_{CES}	—	0.4	mA
Emitter-Base Cutoff Current ($V_{EB} = 5.0\text{ V}, I_C = 0$)	I_{EBO}	—	1.0	mA
ON CHARACTERISTICS (1)				
DC Current Gain ($I_C = 1.0\text{ A}, V_{CE} = 4.0\text{ V}$) ($I_C = 3.0\text{ A}, V_{CE} = 4.0\text{ V}$)	h_{FE}	40 20	— 100	—
Collector-Emitter Saturation Voltage ($I_C = 3.0\text{ A}, I_B = 0.3\text{ A}$) ($I_C = 10\text{ A}, I_B = 2.5\text{ A}$)	$V_{CE(sat)}$	— —	1.0 4.0	Vdc
Base-Emitter On Voltage ($I_C = 3.0\text{ A}, V_{CE} = 4.0\text{ V}$) ($I_C = 10\text{ A}, V_{CE} = 4.0\text{ V}$)	$V_{BE(on)}$	— —	1.6 3.0	Vdc
DYNAMIC CHARACTERISTICS				
Small-Signal Current Gain ($I_C = 0.5\text{ A}, V_{CE} = 10\text{ V}, f = 1.0\text{ kHz}$)	h_{fe}	20	—	—
Current-Gain—Bandwidth Product (2) ($I_C = 0.5\text{ A}, V_{CE} = 10\text{ V}, f = 1.0\text{ MHz}$)	f_T	3.0	—	MHz

(1) Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$.
 (2) $f_T = (h_{fe}) \cdot f_{test}$

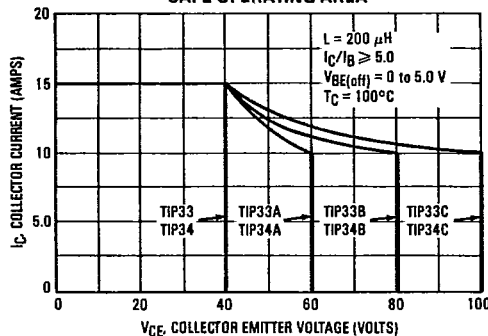
FIGURE 2 — MAXIMUM RATED FORWARD BIAS SAFE OPERATING AREA



FORWARD BIAS

The Forward Bias Safe Operating Area represents the voltage and current conditions these devices can withstand during forward bias. The data is based on $T_C = 25^\circ\text{C}$; $T_J(pk)$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10%, and must be derated thermally for $T_C > 25^\circ\text{C}$.

FIGURE 3 — MAXIMUM RATED REVERSE BIAS SAFE OPERATING AREA



REVERSE BIAS

The Reverse Bias Safe Operating Area represents the voltage and current conditions these devices can withstand during reverse biased turn-off. This rating is verified under clamped conditions so the device is never subjected to an avalanche mode.